| Ref # | Hits | Search Query | DBs | Default Operator | Plurals | Time Stamp |
|----------|------|---|---|---------------------|---------|------------------|
| L2 | 253 | (semiconductor or die or dice or chip or IC) and capacitor same ("SiC" or silicon near carbide) and (via or hole or plug or interconnect\$3) with ("Si" or silicon or silicide or silicone) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/07/21 22:54 |
| L3 | 110 | (semiconductor or die or dice or chip or IC) and capacitor same (dielectric or insulat\$3) with ("SiC" or silicon near carbide) and (via or hole or plug or interconnect\$3) with ("Si" or silicon or silicide or silicone) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/07/21 22:55 |
| L4 | 84 | (semiconductor or die or dice or chip or IC) and capacitor with ("SiC" or silicon near carbide) and (via or hole or plug or interconnect\$3) with ("Si" or silicon or silicide or silicone) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR . | ON | 2005/07/21 22:55 |
| L5 | 66 | 3 not 4 | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/07/21 23:07 |
| L6 | 143 | 2 not 3 | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR. | ON | 2005/07/21 23:09 |
| L7 | 909 | 257/754 | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/07/21 23:37 |
| L8 | 317 | 257/756 | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB | OR | ON | 2005/07/21 23:37 |